

**Search Notes**

Application/Control No.

10/634,229

Examiner

Sun J. Lin

Applicant(s)/Patent under  
Reexamination

BANSAL, JAI P.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	1	3/21/2005	JSL
716	7	3/21/2005	JSL
716	8	3/21/2005	JSL
716	9	3/21/2005	JSL
716	16	3/29/2005	JSL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	16	3/29/2005	JSL
716	7,9	3/21/2005	JSL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	3/21/2005	JSL
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EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	3/23/2005	JSL
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EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	3/29/2005	JSL
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IEEE	3/21/2005	JSL
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GOOGLE	3/21/2005	JSL
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